

***In situ* laser ablation split-stream (LASS-) MC-ICP-MS/ICP-MS for simultaneous determination of Re-Os isotopes and siderophile-chalcophile elements in sulfides: Ablating away a Cornelian dilemma**

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Since the late 90s, both elemental (eg. PGEs) and isotopic *in situ* characterisations of (mantle) sulfides have demonstrated to be powerful tools to unveil and date magmatic processes. Unfortunately often, due to analytical and sample limitations (mantle sulfides $\varnothing < 100 \mu\text{m}$), investigators were left with the dilemma of choosing between trace elements or Re-Os isotopes. Owing to the considerable increase in sensitivity of the newer generations of Nu Instruments MC-ICP-MS [table 1], we were able to perform the first *in situ* LASS-MC-ICP-MS/ICP-MS acquisition of trace elements and Re-Os isotopes from a single ablation. Analytical setting is composed of a Photon-Machines 193nm excimer laser coupled to an Agilent 7700x ICP-MS and a Nu-Plasma II MC-ICP-MS. After ablation in a He atmosphere, the analyte is carried to the spectrometers via 1/8" tubing. The analyte was split using a Y connector. Re-Os measurements were obtained using a mixed array of faraday cups + ion counters [1]. Due to the ion counter limitation, the amount of analyte sent to the Nu Plasma was restricted, thus allowing to divert the excess towards the ICP-MS for PGE and chalcophile-elements abundances. This means, that the implementation of the LASS was done without any sensitivity (thus precision) loss for the MC-ICP-MS.

Instrument	NP I	NP II	NP I	NP II
Mode	Solution		Laser Ablation 65 μm	
Configuration	Faradays Only		Faradays + ICs	
Split-stream	Not applicable		NO	YES
Ref. Material	JM-Os 25 ppb		PGE-A	
Total Os	~8 V	>15 V	~0.10 V	~0.15 V

While count statistics on the ICP-MS were significantly lower ($\approx 50\%$), accuracy and reproducibility for trace elements in reference materials (e.g., Po62, Ai3-W, FeS1) are satisfactory. For instance, [Os] in Po62 was ca. 1.67 ± 0.06 ppm, while [Ir], [Pd] and [Se] were found to be 9.38 ± 0.32 , 9.65 ± 0.55 , 168 ± 1 ppm, respectively, for Ai3-W.

[1] Pearson *et al.*, (2002) *G.C.A.* 66: 1037-1050.